


<b>Search Notes</b>  	<b>Application/Control No.</b>  10599379	<b>Applicant(s)/Patent Under Reexamination</b>  PARK, SANGGU
	<b>Examiner</b>  SHAWNTINA FUQUA	<b>Art Unit</b>  3742

SEARCHED			
Class	Subclass	Date	Examiner
219	528, 552-3	9/9/08	stf
252	510, 511		
524	495-496		
	updated	3/28/09	stf
	updated	9/28/09	stf
	updated	4/26/10	stf

SEARCH NOTES			
Search Notes		Date	Examiner
east, uspgpub, usocr, jpo, epo, derwent, citation		9/9/08	stf
updated		3/28/09	stf
updated		9/28/09	stf
updated		4/26/10	stf

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
219	same	4/26/10	stf
252	as		
524	above		

	/SHAWNTINA FUQUA/ Primary Examiner.Art Unit 3742
--	---